





## $\underline{\texttt{EPS13D2}} \ \underline{\texttt{C}} \ \underline{\texttt{2}} \ \underline{\texttt{H}} \ \underline{\texttt{E}} \ \underline{\texttt{-30.000M}}$

Series —
RoHS Compliant (Pb-free) 3.3V 4 Pad 5mm x 7mm
Ceramic SMD LVCMOS Programmable Spread
Spectrum Oscillator

Nominal Frequency
30.000MHz
Spread Spectrum

Output Control Function Tri-State

±1.50% Center Spread

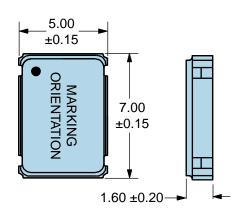
Duty Cycle -50 ±5%

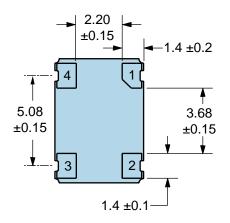
| ELECTRICAL SPECIFICAT                 | ELECTRICAL SPECIFICATIONS  |  |  |
|---------------------------------------|--|--|--|
| Nominal Frequency                     | 30.000MHz  |  |  |
| Frequency Stability                   | ±100ppm Maximum over Operating Temperature of -20°C to +70°C (Inclusive of all conditions: Freque Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Aging at 25°C, Shock, and Vibration.) |  |  |
| Aging at 25°C                         | ±5ppm First Year Maximum   |  |  |
| Supply Voltage                        | 3.3Vdc ±0.3Vdc   |  |  |
| Maximum Supply Voltage                | -0.5Vdc to +7.0Vdc   |  |  |
| Input Current                         | 30mA Maximum (Unloaded; Vdd=3.3Vdc)  |  |  |
| Output Voltage Logic High (Voh)       | Vdd-0.4Vdc Minimum (IOH=-8mA)  |  |  |
| Output Voltage Logic Low (Vol)        | 0.4Vdc Maximum (IOL=+8mA)  |  |  |
| Rise/Fall Time                        | 2.7nSec Maximum (Measured at 20% to 80% of Waveform)   |  |  |
| Duty Cycle                            | 50 ±5% (Measured at 50% of Waveform)   |  |  |
| Load Drive Capability                 | 15pF Maximum   |  |  |
| Output Logic Type                     | CMOS   |  |  |
| Output Control Function               | Tri-State (High Impedance Internal Pull Down Resistor of 100kOhms Typical on Pad 3, Internal Pull Up Resistor of 100kOhms Typical on Pad 1)  |  |  |
| Tri-State Input Voltage (Vih and Vil) | 70% of Vdd Minimum or No Connection to Enable Output, 30% of Vdd Maximum to Disable Output   |  |  |
| Tri-State Output Disable Time         | 350nSec Maximum  |  |  |
| Tri-State Output Enable Time          | 350nSec Maximum  |  |  |
| Disable Current                       | 20mA Maximum (Unloaded; Pad 1=Ground; Vdd=3.3Vdc)  |  |  |
| Spread Spectrum                       | ±1.50% Center Spread   |  |  |
| Modulation Frequency                  | 30kHz Minimum, 31.5kHz Typical, 33kHz Maximum  |  |  |
| Period Jitter                         | 400pSec Maximum (Cycle to Cycle; Spread Spectrum-On; Vdd=3.3Vdc)   |  |  |
| Start Up Time                         | 10mSec Maximum   |  |  |
| Storage Temperature Range             | -55°C to +125°C  |  |  |

| ENVIRONMENTAL & MECHANICAL SPECIFICATIONS |                                       |  |
|---|---------------------------------------|--|
| Fine Leak Test                            | MIL-STD-883, Method 1014, Condition A |  |
| Gross Leak Test                           | MIL-STD-883, Method 1014, Condition C |  |
| Mechanical Shock                          | MIL-STD-202, Method 213, Condition C  |  |
| Resistance to Soldering Heat              | MIL-STD-202, Method 210               |  |
| Resistance to Solvents                    | MIL-STD-202, Method 215               |  |
| Solderability                             | MIL-STD-883, Method 2003              |  |
| Temperature Cycling                       | MIL-STD-883, Method 1010              |  |
| Vibration                                 | MIL-STD-883, Method 2007, Condition A |  |



### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



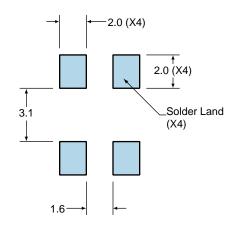


| PIN | CONNECTION     |
|-----|----------------|
| 1   | Tri-State      |
| 2   | Case/Ground    |
| 3   | Output         |
| 4   | Supply Voltage |

| LINE | MARKING   |
|------|---|
| 1    | ECLIPTEK  |
| 2    | 30.000M   |
| 3    | SXXYZZ S=Configuration Designatol XX=Ecliptek Manufacturing Code Y=Last Digit of the Year ZZ=Week of the Year |

#### **Suggested Solder Pad Layout**

All Dimensions in Millimeters



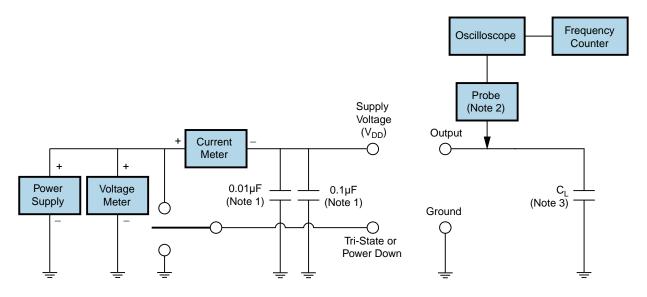
All Tolerances are ±0.1



#### **OUTPUT WAVEFORM & TIMING DIAGRAM**



#### **Test Circuit for CMOS Output**



- Note 1: An external  $0.1\mu F$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu F$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.
- Note 3: Capacitance value  $\dot{C}_L$  includes sum of all probe and fixture capacitance.



# **Recommended Solder Reflow Methods**



### **High Temperature Infrared/Convection**

| T <sub>S</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | 3°C/second Maximum                   |
|---|--------------------------------------|
| Preheat   |                                      |
| - Temperature Minimum (T <sub>s</sub> MIN)          | 150°C                                |
| - Temperature Typical (T <sub>s</sub> TYP)          | 175°C                                |
| - Temperature Maximum (T <sub>s</sub> MAX)          | 200°C                                |
| - Time (t <sub>s</sub> MIN)                         | 60 - 180 Seconds                     |
| Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )    | 3°C/second Maximum                   |
| Time Maintained Above:                              |                                      |
| - Temperature (T∟)                                  | 217°C                                |
| - Time (t∟)   | 60 - 150 Seconds                     |
| Peak Temperature (T <sub>P</sub> )                  | 260°C Maximum for 10 Seconds Maximum |
| Target Peak Temperature (T <sub>P</sub> Target)     | 250°C +0/-5°C                        |
| Time within 5°C of actual peak (tp)                 | 20 - 40 seconds                      |
| Ramp-down Rate                                      | 6°C/second Maximum                   |
| Time 25°C to Peak Temperature (t)                   | 8 minutes Maximum                    |
| Moisture Sensitivity Level                          | Level 1                              |



## **Recommended Solder Reflow Methods**



#### Low Temperature Infrared/Convection 240°C

| T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | 5°C/second Maximum                                     |
|---|--|
| Preheat   |  |
| - Temperature Minimum (T <sub>S</sub> MIN)          | N/A  |
| - Temperature Typical (T <sub>s</sub> TYP)          | 150°C  |
| - Temperature Maximum (T <sub>s</sub> MAX)          | N/A  |
| - Time (t <sub>s</sub> MIN)                         | 60 - 120 Seconds                                       |
| Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )    | 5°C/second Maximum                                     |
| Time Maintained Above:                              |  |
| - Temperature (T <sub>L</sub> )                     | 150°C  |
| - Time (t∟)   | 200 Seconds Maximum                                    |
| Peak Temperature (T <sub>P</sub> )                  | 240°C Maximum  |
| Target Peak Temperature (T <sub>P</sub> Target)     | 240°C Maximum 1 Time / 230°C Maximum 2 Times           |
| Time within 5°C of actual peak (t <sub>p</sub> )    | 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time |
| Ramp-down Rate                                      | 5°C/second Maximum                                     |
| Time 25°C to Peak Temperature (t)                   | N/A  |
| Moisture Sensitivity Level                          | Level 1  |

#### **Low Temperature Manual Soldering**

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum.